# Tin Thurein

EIT License: 166315 · Electrical Engineer · Hardware Enthusiast

San Francisco

## Summary

Highly motivated electrical engineer with expertise in Electrical, Mechanical, and Communication engineering with hands-on experience focused on solving challenges in energy, transportation, and sustainability.

### Skills

- Software Engineering: C,C++, Python, Java, VHDL
- **H/W Engineering:** Xilinx FPGA, Analog, Mixed Signal & Power electronics circuit design, Logic Design, DSP, Circuit & PCB Simulation
- Embedded Systems: AVR, STM32, PIC, CAN, I2C, UART, SPI, SpW, JESD204, Sensor interface, Protocol debugging hardware
- **Software:** Orcad, Allegro PCB Design, Eagle CAD, Mentor Graphics Xpedition, SPICE, HyperLynx, Vivado, National Instrument Circuit Suite, SolidWorks, Autodesk Inventor, MATLAB

# **Professional Experience**

Sr. R&D Electrical Engineer at Sandia National Laboratories

Livermore, CA 08/2023 - present

• Hardware engineer for high-speed, high-performance telemetry interfacing board.

### **Electrical Design Engineer** at KLA-Tencor

Milpitas, CA 06/2022 - 08/2023

- Designed functional test fixtures (FUT) for stage motion controller PCBs, integrating high-speed ADCs, DACs, LVDS transceivers, and digital communication protocols including UART, SPI, and I2C to interface with FPGA.
- Developed embedded firmware and libraries for Functional Test Fixtures (FUT) and FPGA test-mode firmware.
- Authored Interface Control Document (ICD) specifications, and maintained Python scripts for automating test procedures and GUI.
- Conducted SPICE simulations, Power and Signal Integrity analyses utilizing HyperLynx.
- Designed high-speed stage motion controller board, managing the entire PCB design cycle from schematics capture, reviewing layout, PCB manufacturing to hardware bring-up and functional verification.
- Sr. Reliability Hardware & ESD/Latch-up Engineer at Analog Devices Milpitas, CA 07/2019 06/2022
- Responsible for reliability circuit designs and test setup development for accelerated testing of packaged and wafer-level chip-scale packaged devices.
- Developed and implemented reliability test plans for new products, including High-Temperature Operating Life (HTOL), Highly Accelerated Temperature and Humidity Stress (HAST), and Early Life Failure Rate (EFLR) tests.
- Troubleshooted PCB boards to identify root causes of failures occurring during burn-in or HAST cycles.
- Defined and developed ESD and Latch-up methodologies for new, existing, and fab-transferred products, ensuring characterization of ESD and Latch-up properties in accordance with JESD and AECQ standards.
- Developed and executed ESD/Latch-up device characterization plans, and conducted comprehensive data analysis on ESD/Latch-up related failures.

#### **Engineering: R&D Product Development** at Nordson March

Concord, CA 10/2017 - 07/2019

- Responsible for integrating EFEM (Equipment Front End Module) systems with plasma modules.
- Configured high-power RF generators and RF matching networks, and developed process recipes for various plasma and chemical deposition applications.
- Designed and tested new vacuum chambers and High-Flux Electrode (HFE) configurations.
- Enhanced process cycle time for customers by developing process recipes and optimizing RF power delivery systems and RF matching networks, achieving superior plasma treatment, uniformity, and throughput.
- Conducted Factory Acceptance Tests (FAT), trained customers, and performed QA and QC procedures on product shipments.

### **Education**

M.S. in Electrical Engineering at University of California, Santa Cruz

**Santa Cruz, CA** 2020-2022

Research Areas: Neuromorphic computing, Memristors, Spiking Neural Networks, Memristive Integrate-and-Fire

**B.E. in Electrical Engineering** at University of California, Santa Cruz

Santa Cruz, CA 2017-2019

Concentration: Electronics/ Optoelectronics